

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of :
Masahiko MUTOH : Confirmation No.7766
Divisional of :
U.S. Patent Application No. 09/679,079 : Group Art Unit: 2634
Filed: *Herewith* : Examiner: AHN, SAM K.

For: AN APPARATUS AND A METHOD FOR CALCULATION OF A CORRELATION VALUE
CORRESPONDING TO A FREQUENCY ERROR AND A RECORDING MEDIUM WITH A RECORDED
CORRELATION VALUE CALCULATION PROGRAM

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

In accordance with the provisions of 37 C.F.R. 1.56, 1.97 and 1.98, the attention of the Patent and Trademark Office is hereby directed to the documents listed on the attached form PTO-1449. It is respectfully requested that the documents be expressly considered during the prosecution of this application, and that the documents be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

This Information Disclosure Statement is being filed within three months after the U.S. filing date or before the mailing date of a first Office Action on the merits. No certification or fee is required.

The references were cited by or submitted to the U.S. Patent and Trademark Office in Parent Application No. 09/679,079, filed October 5, 2000, which is relied upon for an earlier filing date under 35 USC 120. Thus copies of these references are not attached. 37 CFR 1.98 (d).

Respectfully submitted,

LOWE HAUPTMAN GILMAN & BERNER, LLP

Kenneth M. Berner

Kenneth M. Berner
Registration No. 37,093

1700 Diagonal Road, Suite 300
Alexandria, Virginia 22314
(703) 684-1111 KMB/iyf
Facsimile: (703) 518-5499
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INFORMATION DISCLOSURE CITATION IN AN APPLICATION							
(PTO-1449)							
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APPLICANT Masahiko MUTOH							
FILING DATE October 5, 2000				GROUP 2634			
U.S. PATENT DOCUMENTS							
EXAMINER'S INITIALS	PATENT NO.	DATE	NAME	CLASS	SUBCLASS	FILING DATE	
	5,822,365	10/13/98	Lee				
FOREIGN PATENT DOCUMENTS							
EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
	KR-0162831	12/1/98	Korea			Yes	No
	KR-0186590	5/15/99	Korea				
OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)							
EXAMINER				DATE CONSIDERED			

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.